

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/070,265	<b>Applicant(s)/Patent under Reexamination</b> NISHIYAMA, KOHEI
<b>Examiner</b> Nathan Erb	<b>Art Unit</b> 3628	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner